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Application/Control No.	Applicant(s)/Patent under Reexamination		
09/841,666	TANAKA ET AL.		
Examiner	Art Unit		

2871

HOAN C. NGUYEN

	SEARCHED			
Class	Subclass	Date	Examiner	
349	update	12/28/2006	CHN	

INT	INTERFERENCE SEARCHED			
Class	Subclass	Date	Examiner	
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1	SEARCH NOTES (INCLUDING SEARCH STRATEGY)				
		DATE	EXMR		
EAST		12/28/2006	CHN		
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